General Description
The MAX31722/MAX31723 digital thermometers and thermostats with an SPI/3-wire interface provide temperature readings that indicate the device temperature. No additional components are required; the devices are truly temperature-to-digital converters. Temperature readings are communicated from the device over an SPI interface or a 3-wire serial interface. The choice of interface is selectable by the user. For applications that require greater temperature resolution, the user can adjust the readout resolution from 9 to 12 bits. This is particularly useful in applications where thermal runaway conditions must be detected quickly. The thermostat has a dedicated open-drain output (TOUT). Two thermostat operating modes, comparator and interrupt, control thermostat operation based on user-defined nonvolatile trip points (THIGH and TLOW). Both devices feature a 1.7V to 3.7V supply rail.

Benefits and Features
- Maximize System Accuracy in Broad Range of Thermal Management Applications
- Measures Temperature from -55°C to +125°C
- MAX31722 Thermometer Accuracy of ±2°C
- MAX31723 Thermometer Accuracy of ±0.5°C
- Configurable Resolution from 9 Bits to 12 Bits (0.5°C to 0.0625°C Resolution)
- Reduce Cost with No External Components
- Extend Performance with Low-Voltage, 1.7V to 3.7V Power-Supply Range
- Dedicated Thermostat Output with Nonvolatile User-Defined Thresholds for Quick Detection
- Selectable SPI or 3-Wire Interface for Added Flexibility
- Available in 8-Pin µMAX® Package for Board Space Savings

Applications
- Networking Equipment
- Cellular Base Stations
- Industrial Equipment
- Any Thermally Sensitive Systems

Functional Diagram

<table>
<thead>
<tr>
<th>PART</th>
<th>TEMP RANGE</th>
<th>PIN-PACKAGE</th>
</tr>
</thead>
<tbody>
<tr>
<td>MAX31722MUA+</td>
<td>-55°C to +125°C</td>
<td>8 µMAX</td>
</tr>
<tr>
<td>MAX31722MUA+T</td>
<td>-55°C to +125°C</td>
<td>8 µMAX</td>
</tr>
<tr>
<td>MAX31723MUA+</td>
<td>-55°C to +125°C</td>
<td>8 µMAX</td>
</tr>
<tr>
<td>MAX31723MUA+T</td>
<td>-55°C to +125°C</td>
<td>8 µMAX</td>
</tr>
</tbody>
</table>

µMAX is a registered trademark of Maxim Integrated Products, Inc.
Absolute Maximum Ratings

- Voltage Range on VDD Relative to GND: -0.3V to +6.0V
- Voltage Range on Any Other Pin Relative to GND: -0.3V to +6.0V
- Continuous Power Dissipation (TA = +70°C): μMAX (derate 4.5mW/°C above +70°C) = 362mW
- EEPROM Programming Temperature Range: -40°C to +85°C
- Operating Junction Temperature Range: -55°C to +125°C
- Storage Temperature Range: -55°C to +125°C
- Lead Temperature (soldering, 10s): +300°C
- Soldering Temperature (reflow): +260°C

Stresses beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Recommended Operating Characteristics

(TJ = -55°C to +125°C, unless otherwise noted.)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>SYMBOL</th>
<th>CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNITS</th>
</tr>
</thead>
<tbody>
<tr>
<td>Supply Voltage</td>
<td>VDD (Note 1)</td>
<td>1.7</td>
<td>3.7</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Input Logic-High</td>
<td>VIH (Note 1)</td>
<td>0.7 x VDD</td>
<td>VDD + 0.3</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Input Logic-Low</td>
<td>VIL (Note 1)</td>
<td>-0.3</td>
<td>0.3 x VDD</td>
<td>V</td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

DC Electrical Characteristics

(VDD = 1.7V to 3.7V, TJ = -55°C to +125°C, unless otherwise noted.)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>SYMBOL</th>
<th>CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNITS</th>
</tr>
</thead>
<tbody>
<tr>
<td>MAX31722 Thermometer Error</td>
<td>TERR -40°C to +85°C</td>
<td>±2.0</td>
<td>°C</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>TERR -55°C to +125°C</td>
<td>±3.0</td>
<td>°C</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>MAX31723 Thermometer Error</td>
<td>TERR 0°C to +70°C</td>
<td>±0.5</td>
<td>°C</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>TERR -55°C to +125°C</td>
<td>±2.0</td>
<td>°C</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Resolution</td>
<td>9</td>
<td>12</td>
<td>Bits</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Conversion Time</td>
<td>ICONVT 9-bit conversions</td>
<td>25</td>
<td>ms</td>
<td></td>
<td></td>
<td></td>
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<tr>
<td></td>
<td>10-bit conversions</td>
<td>50</td>
<td></td>
<td></td>
<td></td>
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<tr>
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<td>11-bit conversions</td>
<td>100</td>
<td></td>
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<td></td>
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<tr>
<td></td>
<td>12-bit conversions</td>
<td>200</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Logic 0 Output (SDO, TOUT)</td>
<td>VOUT (Note 2)</td>
<td>0.4</td>
<td>V</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Logic 1 Output (SDO)</td>
<td>VOH (Note 3)</td>
<td>VDD - 0.4</td>
<td>V</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Leakage Current</td>
<td>IL -1</td>
<td>+1</td>
<td>μA</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Active Current</td>
<td>ICC Active temperature conversions (Note 4)</td>
<td>1150</td>
<td>μA</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>Communication only</td>
<td>100</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>EEPROM writes (-40°C to +85°C)</td>
<td>1150</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>EEPROM writes during active temperature conversions (-40°C to +85°C)</td>
<td>1200</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Shutdown Current</td>
<td>ICC1</td>
<td>2</td>
<td>μA</td>
<td></td>
<td></td>
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AC Electrical Characteristics: 3-Wire Interface

(VDD = 1.7V to 3.7V, TJ = -55°C to +125°C, unless otherwise noted.) (Figures 1, 2)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>SYMBOL</th>
<th>CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNITS</th>
</tr>
</thead>
<tbody>
<tr>
<td>Data to SCLK Setup</td>
<td>tDC</td>
<td>(Notes 5, 6)</td>
<td>35</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>SCLK to Data Hold</td>
<td>tCDH</td>
<td>(Notes 5, 6)</td>
<td>35</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>SCLK to Data Valid</td>
<td>tCDD</td>
<td>(Notes 5, 6, 7)</td>
<td>80</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>SCLK Low Time</td>
<td>tCL</td>
<td>(Note 6)</td>
<td>100</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>SCLK High Time</td>
<td>tCH</td>
<td>(Note 6)</td>
<td>100</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>SCLK Frequency</td>
<td>tCLK</td>
<td>(Note 6)</td>
<td>DC</td>
<td>5.0</td>
<td></td>
<td>MHz</td>
</tr>
<tr>
<td>SCLK Rise and Fall</td>
<td>tr, tf</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>CE to SCLK Setup</td>
<td>tCC</td>
<td>(Note 6)</td>
<td>400</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>SCLK to CE Hold</td>
<td>tCCH</td>
<td>(Note 6)</td>
<td>100</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>CE Inactive Time</td>
<td>tCWH</td>
<td>(Note 6)</td>
<td>400</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>CE to Output High-Z</td>
<td>tCDZ</td>
<td>(Notes 5, 6)</td>
<td>40</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>SCLK to Output High-Z</td>
<td>tCCZ</td>
<td>(Notes 5, 6)</td>
<td>40</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
</tbody>
</table>

AC Electrical Characteristics: SPI Interface

(VDD = 1.7V to 3.7V, TJ = -55°C to +125°C, unless otherwise noted.) (Figures 3, 4)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>SYMBOL</th>
<th>CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNITS</th>
</tr>
</thead>
<tbody>
<tr>
<td>Data to SCLK Setup</td>
<td>tDC</td>
<td>(Notes 5, 6)</td>
<td>35</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>SCLK to Data Hold</td>
<td>tCDH</td>
<td>(Notes 5, 6)</td>
<td>35</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>SCLK to Data Valid</td>
<td>tCDD</td>
<td>(Notes 5, 6, 7)</td>
<td>80</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>SCLK Low Time</td>
<td>tCL</td>
<td>(Note 6)</td>
<td>100</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>SCLK High Time</td>
<td>tCH</td>
<td>(Note 6)</td>
<td>100</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>SCLK Frequency</td>
<td>tCLK</td>
<td>(Note 6)</td>
<td>DC</td>
<td>5.0</td>
<td></td>
<td>MHz</td>
</tr>
<tr>
<td>SCLK Rise and Fall</td>
<td>tr, tf</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>CE to SCLK Setup</td>
<td>tCC</td>
<td>(Note 6)</td>
<td>400</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>SCLK to CE Hold</td>
<td>tCCH</td>
<td>(Note 6)</td>
<td>100</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>CE Inactive Time</td>
<td>tCWH</td>
<td>(Note 6)</td>
<td>400</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>CE to Output High-Z</td>
<td>tCDZ</td>
<td>(Notes 5, 6)</td>
<td>40</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>SCLK to Output High-Z</td>
<td>tCCZ</td>
<td>(Notes 5, 6)</td>
<td>40</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
</tbody>
</table>

AC Electrical Characteristics: EEPROM

(VDD = 1.7V to 3.7V, TJ = -55°C to +125°C, unless otherwise noted.)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>SYMBOL</th>
<th>CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNITS</th>
</tr>
</thead>
<tbody>
<tr>
<td>EEPROM Write Cycle Time</td>
<td>tWR</td>
<td>-40°C to +85°C (Note 8)</td>
<td>15</td>
<td></td>
<td></td>
<td>ms</td>
</tr>
<tr>
<td>EEPROM Write Endurance</td>
<td>NEWR</td>
<td>-40°C ≤ TA ≤ +85°C (Note 8)</td>
<td>20,000</td>
<td></td>
<td></td>
<td>Cycles</td>
</tr>
<tr>
<td></td>
<td></td>
<td>TA = +25°C (Note 8)</td>
<td>80,000</td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

Note 1: All voltages are referenced to ground. Currents entering the IC are specified positive, and currents exiting the IC are negative.
Note 2: Logic 0 voltages are specified at a sink current of 3mA.
Note 3: Logic 1 voltages are specified at a source current of 1mA.
Note 4: ICC specified with SCLK = VDD and CE = GND.
Note 5: Measured at VIL = 0.7V x VDD or VIH = 0.3 x VDD and 10ms maximum rise and fall times.
Note 6: Measured with 50pF load.
Note 7: Measured at VIL = 0.7 x VDD or VIH = 0.3 x VDD. Measured from the 50% point of SCLK to the VOH minimum of SDO.
Note 8: VDD must be > 2.0V during EEPROM write cycles.
Figure 1. Timing Diagram: 3-Wire Read Data Transfer

Figure 2. Timing Diagram: 3-Wire Write Data Transfer
Figure 3. Timing Diagram: SPI Read Data Transfer

Figure 4. Timing Diagram: SPI Write Data Transfer
Typical Operating Characteristics
(T$_A$ = +25°C, unless otherwise noted.)
Detailed Description

The MAX31722/MAX31723 are factory-calibrated temperature sensors that require no external components. The user can alter the configuration/status register to place the device in a continuous temperature conversion mode or into a one-shot conversion mode. In the continuous conversion mode, the devices continuously convert the temperature and store the result in the temperature register. As conversions are performed in the background, reading the temperature register does not affect the conversion in progress. In the one-shot temperature conversion mode, the devices perform one temperature conversion, store the result in the temperature register, and then return to the shutdown state. This conversion mode is ideal for power-sensitive applications. The temperature conversion results have a default resolution of 9 bits. In applications where small incremental temperature changes are critical, the user can change the conversion resolution from 9 bits to 10, 11, or 12. This is accomplished by programming the configuration/status register.

The devices can be configured as a thermostat, allowing for the TOUT pin to behave as an interrupt, triggering when the programmed limits, \( T_{HIGH} \) and \( T_{LOW} \), are surpassed. The devices can communicate using either a serial peripheral interface (SPI) or standard 3-wire interface. The user can select either communication standard through the SERMODE pin, connecting it to \( V_{DD} \) for SPI and to GND for 3-wire.
Measuring Temperature
The core of the devices’ functionality is its direct-to-digital temperature sensor. The devices measure temperature through the use of an on-chip temperature measurement technique with a -55°C to +125°C operating range. The devices power up in a power-conserving shutdown mode. After power-up, the devices can be placed in a continuous conversion mode or in a one-shot conversion mode. In the continuous conversion mode, the devices continuously compute the temperature and store the most recent result in the temperature register at addresses 01h (LSB) and 02h (MSB). As conversions are performed in the background, reading the temperature register does not affect the conversion in progress. The temperature value is not updated until the SPI or 3-wire interface is inactive. In other words, CE must be inactive for the temperature register to be updated with the most recent temperature conversion value. In the one-shot conversion mode, the devices perform one temperature conversion and then return to the shutdown mode, storing temperature in the temperature register. This conversion mode is ideal for power-sensitive applications. Details on how to change the setting after power-up are contained in the Programming section.

The resolution of the temperature conversion is configurable (9, 10, 11, or 12 bits) with 9 bits reading the default state. This equates to a temperature resolution of 0.5°C, 0.25°C, 0.125°C, or 0.0625°C. Following each conversion, thermal data is stored in the temperature register in two’s complement format. The information can be retrieved over the SPI or 3-wire interface with the address set to the temperature register, 01h (LSB) and then 02h (MSB). Table 1 describes the exact relationship of output data to measured temperature. Table 1 assumes the devices are configured for 12-bit resolution. If the devices are configured in a lower resolution mode, those bits contain zeros. The data is transmitted serially over the digital interface, MSB first for SPI communication and LSB first for 3-wire communication. The MSB of the temperature register contains the sign (S) bit, denoting whether the temperature is positive or negative.

<table>
<thead>
<tr>
<th>TEMPERATURE (°C)</th>
<th>DIGITAL OUTPUT (BINARY)</th>
<th>DIGITAL OUTPUT (HEX)</th>
</tr>
</thead>
<tbody>
<tr>
<td>+125</td>
<td>0111 1101 0000 0000</td>
<td>7D00</td>
</tr>
<tr>
<td>+25.0625</td>
<td>0001 1011 0001 0000</td>
<td>1910</td>
</tr>
<tr>
<td>+10.125</td>
<td>0000 1010 0010 0000</td>
<td>0A20</td>
</tr>
<tr>
<td>+0.5</td>
<td>0000 0000 1000 0000</td>
<td>0080</td>
</tr>
<tr>
<td>0</td>
<td>0000 0000 0000 0000</td>
<td>0000</td>
</tr>
<tr>
<td>-0.5</td>
<td>1111 1111 1000 0000</td>
<td>FF80</td>
</tr>
<tr>
<td>-10.125</td>
<td>1111 0101 1110 0000</td>
<td>F5E0</td>
</tr>
<tr>
<td>-25.0625</td>
<td>1110 0110 1111 0000</td>
<td>E6F0</td>
</tr>
<tr>
<td>-55</td>
<td>1100 1001 0000 0000</td>
<td>C900</td>
</tr>
</tbody>
</table>

Figure 5. Temperature, T_HIGH, and T_LOW Register Format

Table 1. 12-Bit Resolution Temperature/Data Relationship
Thermostat

The devices' thermostat can be programmed to power up in either comparator mode or interrupt mode, which activate and deactivate the open-drain thermostat output (TOUT) based on user-programmable trip points (T\text{HIGH} and T\text{LOW}). The T\text{HIGH} and T\text{LOW} registers contain Celsius temperature values in two’s complement format and are stored in EEPROM memory. As such, the values are nonvolatile and can be programmed prior to installing the devices for stand-alone operation.

The data format of the T\text{HIGH} and T\text{LOW} registers is identical to that of the temperature register (Figure 5). After every temperature conversion, the measurement is compared to the values stored in the T\text{HIGH} and T\text{LOW} registers. The T\text{HIGH} register is assigned to address locations 03h (LSB) and 04h (MSB), and the T\text{LOW} register is assigned to address locations 05h (LSB) and 06h (MSB). The TOUT output is updated based on the result of the comparison and the operating mode of the devices. The number of T\text{HIGH} and T\text{LOW} bits used during the thermostat comparison is equal to the conversion resolution set by the R1 and R0 bits in the configuration/status register. For example, if the resolution is 9 bits, only the nine MSBs of T\text{HIGH} and T\text{LOW} are used by the thermostat comparator.

If the user does not wish to use the thermostat capabilities of the devices, the TOUT output should be left unconnected. Note that if the thermostat is not used, the T\text{HIGH} and T\text{LOW} registers can be used for general storage of system data.

Comparator Mode

When the thermostat is in comparator mode, TOUT can be programmed to operate with any amount of hysteresis. The TOUT output becomes active when the measured temperature exceeds the T\text{HIGH} value. TOUT then stays active until the first time the temperature falls below the value stored in T\text{LOW}. Putting the devices into shutdown mode does not clear TOUT in comparator mode. Figure 6 illustrates thermostat comparator mode operation.

Interrupt Mode

In interrupt mode, the TOUT output first becomes active when the measured temperature exceeds the T\text{HIGH} value. Once activated, in continuous conversion mode TOUT can only be cleared by either putting the devices into shutdown mode or by reading from any register (configuration/status, temperature, T\text{HIGH}, or T\text{LOW}) on the devices. In one-shot mode, TOUT can only be cleared by reading from any register (configuration/status, temperature, T\text{HIGH}, or T\text{LOW}) on the devices. In
either mode, once $T_{OUT}$ has been deactivated, it is only reactivated when the measured temperature falls below the $T_{LOW}$ value. Thus, this interrupt/clear process is cyclical between $T_{HIGH}$ and $T_{LOW}$ events (i.e., $T_{HIGH}$, clear, $T_{LOW}$, clear, $T_{HIGH}$, clear, $T_{LOW}$, clear, etc.). Figure 6 illustrates the thermostat interrupt mode operation.

### Table 2. Register Address Structure

<table>
<thead>
<tr>
<th>READ ADDRESS (HEX)</th>
<th>WRITE ADDRESS (HEX)</th>
<th>ACTIVE REGISTER</th>
</tr>
</thead>
<tbody>
<tr>
<td>00</td>
<td>80</td>
<td>Configuration/Status</td>
</tr>
<tr>
<td>01</td>
<td>No access</td>
<td>Temperature LSB</td>
</tr>
<tr>
<td>02</td>
<td>No access</td>
<td>Temperature MSB</td>
</tr>
<tr>
<td>03</td>
<td>83</td>
<td>$T_{HIGH}$ LSB</td>
</tr>
<tr>
<td>04</td>
<td>84</td>
<td>$T_{HIGH}$ MSB</td>
</tr>
<tr>
<td>05</td>
<td>85</td>
<td>$T_{LOW}$ LSB</td>
</tr>
<tr>
<td>06</td>
<td>86</td>
<td>$T_{LOW}$ MSB</td>
</tr>
</tbody>
</table>

### Table 3. Configuration/Status Register Bit Descriptions

<table>
<thead>
<tr>
<th>BIT 7</th>
<th>BIT 6</th>
<th>BIT 5</th>
<th>BIT 4</th>
<th>BIT 3</th>
<th>BIT 2</th>
<th>BIT 1</th>
<th>BIT 0</th>
<th>MEMW</th>
<th>NVB</th>
<th>1SHOT</th>
<th>TM</th>
<th>R1</th>
<th>R0</th>
<th>SD</th>
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</thead>
<tbody>
<tr>
<td>0</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td>MEMW</td>
<td>NVB</td>
<td>1SHOT</td>
<td>TM</td>
<td>R1</td>
<td>R0</td>
<td>SD</td>
</tr>
</tbody>
</table>

- **BIT 7**: This bit is always a value of 0.

- **BIT 6**: MEMW: Memory write bit. Power-up state = 0. The user has read/write access to the MEMW bit, which is stored in the voltage memory.
  0 = A write of the configuration/status register is stored in RAM memory.
  1 = A write of the configuration/status register is stored in EEPROM.

  **Note**: The status of this bit is ignored if a EEPROM write occurs to the other nonvolatile registers, $T_{HIGH}$ and $T_{LOW}$. The nonvolatile bits of the configuration/status register are written if a EEPROM write cycle occurs to the $T_{HIGH}$ and $T_{LOW}$ registers.

- **BIT 5**: NVB: Nonvolatile memory busy flag. Power-up state = 0 and is stored in volatile memory.
  0 = Indicates that the nonvolatile memory is not busy.
  1 = Indicates there is a write to a EEPROM memory cell in progress.

- **BIT 4**: 1SHOT: One-shot temperature conversion bit. Power-up state = 0 and is stored in volatile memory.
  0 = Disables 1SHOT mode.
  1 = If the SD bit is 1 (continuous temperature conversions are not taking place), a 1 written to the 1SHOT bit causes the devices to perform one temperature conversion and store the results in the temperature register at addresses 01h (LSB) and 02h (MSB). The bit clears itself to 0 upon completion of the temperature conversion. The user has read/write access to the 1SHOT bit, although writes to this bit are ignored if the SD bit is a 0 (continuous conversion mode).

- **BIT 3**: TM: Thermostat operating mode. Factory power-up state = 0. The user has read/write access to the TM bit, which is stored in nonvolatile memory.
  0 = The thermostat output is in comparator mode.
  1 = The thermostat output is in interrupt mode.

**Programming**

The area of interest in programming the devices is the configuration/status register. All programming is done through the SPI or 3-wire communication interface by selecting the appropriate address of the desired register location. Table 2 illustrates the addresses for the device registers.

**Configuration/Status Register Programming**

The configuration/status register is accessed in the devices with the 00h address for reads and the 80h address for writes. Data is read from or written to the configuration/status register MSB first for SPI communication and LSB first for 3-wire communication. Table 3 illustrates the format of the register, describes the effect each bit has on device functionality, and provides the bit's factory state.

Table 4 defines the resolution of the digital thermometer, based on the settings of the R1 and R0 bits. There is a direct trade-off between resolution and conversion time,
Table 3. Configuration/Status Register Bit Descriptions (continued)

<table>
<thead>
<tr>
<th>BIT 2</th>
<th>R1: Thermostat resolution bit 1. Factory power-up state = 0 and is stored in nonvolatile memory. Sets the conversion resolution (see Table 4).</th>
</tr>
</thead>
<tbody>
<tr>
<td>BIT 1</td>
<td>R0: Thermostat resolution bit 0. Factory power-up state = 0 and is stored in nonvolatile memory. Sets the conversion resolution (see Table 4).</td>
</tr>
</tbody>
</table>
| BIT 0 | SD: Factory power-up state = 1. The user has read/write access to the SD bit, which is stored in nonvolatile memory.  
  0 = The devices continuously perform temperature conversions and store the last completed result in the temperature register.  
  1 = The conversion in progress is completed and stored, and then the devices revert to a low-power shutdown mode. The communication port remains active. |

Table 4. Thermometer Resolution Configuration

<table>
<thead>
<tr>
<th>R1</th>
<th>R0</th>
<th>THERMOMETER RESOLUTION (BITS)</th>
<th>MAX CONVERSION TIME (ms)</th>
</tr>
</thead>
<tbody>
<tr>
<td>0</td>
<td>0</td>
<td>9</td>
<td>25</td>
</tr>
<tr>
<td>0</td>
<td>1</td>
<td>10</td>
<td>50</td>
</tr>
<tr>
<td>1</td>
<td>0</td>
<td>11</td>
<td>100</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
<td>12</td>
<td>200</td>
</tr>
</tbody>
</table>

Table 5. Function Table

<table>
<thead>
<tr>
<th>MODE</th>
<th>CE</th>
<th>SCLK</th>
<th>SDI</th>
<th>SDO</th>
</tr>
</thead>
<tbody>
<tr>
<td>Disable reset</td>
<td>Low</td>
<td>Input disabled</td>
<td>Input disabled</td>
<td>High impedance</td>
</tr>
<tr>
<td>Write</td>
<td>High</td>
<td>CPOL = 1*, SCLK rising</td>
<td>Data bit latch</td>
<td>High impedance</td>
</tr>
<tr>
<td></td>
<td></td>
<td>CPOL = 0, SCLK falling</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Read</td>
<td>High</td>
<td>CPOL = 1, SCLK falling</td>
<td>X</td>
<td>Next data bit shift**</td>
</tr>
<tr>
<td></td>
<td></td>
<td>CPOL = 0, SCLK rising</td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

Note: CPHA bit polarity must be set to 1.
*CPOL is the clock polarity bit that is set in the control register of the microcontroller.
**SDO remains at high impedance until 8 bits of data are ready to be shifted out during a read.

as depicted in the AC Electrical Characteristics. The user has read/write access to the R1 and R0 bits, which are nonvolatile. See Table 4.

Serial Interface

The devices offer the flexibility to choose between two serial interface modes. They can communicate with the SPI interface or with a 3-wire interface. The interface method used is determined by the SERMODE pin. When SERMODE is connected to VDD, SPI communication is selected. When SERMODE is connected to ground, 3-wire communication is selected.

Table 5. Function Table

<table>
<thead>
<tr>
<th>MODE</th>
<th>CE</th>
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<th>SDI</th>
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</tr>
<tr>
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<td></td>
<td></td>
</tr>
</tbody>
</table>

Note: CPHA bit polarity must be set to 1.
*CPOL is the clock polarity bit that is set in the control register of the microcontroller.
**SDO remains at high impedance until 8 bits of data are ready to be shifted out during a read.
Address and Data Bytes
Address and data bytes are shifted MSB first into the serial-data input (SDI) and out of the serial-data output (SDO). Any transfer requires the address of the byte to specify a write or a read, followed by one or more bytes of data. Data is transferred out of the SDO for a read operation and into the SDI for a write operation. The address byte is always the first byte entered after CE is driven high. The MSB (A7) of this byte determines if a read or write takes place. If A7 is 0, one or more read cycles occur. If A7 is 1, one or more write cycles occur.

Data transfers can occur 1 byte at a time in multiple-byte burst mode. After CE is driven high, an address is written to the devices. After the address, one or more data bytes can be written or read. For a single-byte transfer, 1 byte is read or written and then CE is driven low (see Figures 8 and 9). For a multiple-byte transfer, however, multiple bytes can be read or written to the devices after the address has been written (see Figure 10). A single-byte burst read/write sequentially points through all memory locations and loops from 7Fh/FFh to 00h/80h. Invalid memory addresses report an FFh value.

3-Wire Serial-Data Bus
The 3-wire communication mode operates similarly to the SPI mode. However, in 3-wire mode, there is one bidirectional I/O instead of separate data-in and data-out signals. The 3-wire consists of the I/O (SDI and SDO pins connected together), CE, and SCLK pins. In 3-wire mode, each byte is shifted in LSB first, unlike SPI mode where each byte is shifted in MSB first. As is the case with the SPI mode, an address byte is written to the devices followed by a single data byte or multiple data bytes. Figure 11 illustrates a read and write cycle. Figure 12 illustrates a multiple-byte burst transfer. In 3-wire mode, data is input on the rising edge of SCLK and output on the falling edge of SCLK.
Figure 8. SPI Single-Byte Read

Figure 9. SPI Single-Byte Write

Figure 10. SPI Multiple-Byte Burst Transfer
Package Information
For the latest package outline information and land patterns, go to www.maximintegrated.com/packages. Note that a "+", "#", or ":" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.

<table>
<thead>
<tr>
<th>PACKAGE TYPE</th>
<th>PACKAGE CODE</th>
<th>OUTLINE NO.</th>
<th>LAND PATTERN NO.</th>
</tr>
</thead>
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<td>8 µMAX</td>
<td>U8+1</td>
<td>21-0036</td>
<td>90-0092</td>
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Revision History

<table>
<thead>
<tr>
<th>REVISION NUMBER</th>
<th>REVISION DATE</th>
<th>DESCRIPTION</th>
<th>PAGES CHANGED</th>
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</thead>
<tbody>
<tr>
<td>0</td>
<td>11/10</td>
<td>Initial release</td>
<td>—</td>
</tr>
<tr>
<td>1</td>
<td>3/15</td>
<td>Updated Benefits and Features section on page 1</td>
<td>1</td>
</tr>
</tbody>
</table>